Sear	ch N	lotes



Application/Control No.

Applicant(s)/Patent under Reexamination
LEHR ET AL.

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Examiner

Art Unit

Vincent T. Tran

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	SEARCHED			
Class	Subclass	Date	Examiner	
713	300	3/13/2007	VT	
713	340	3/13/2007	VT	
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